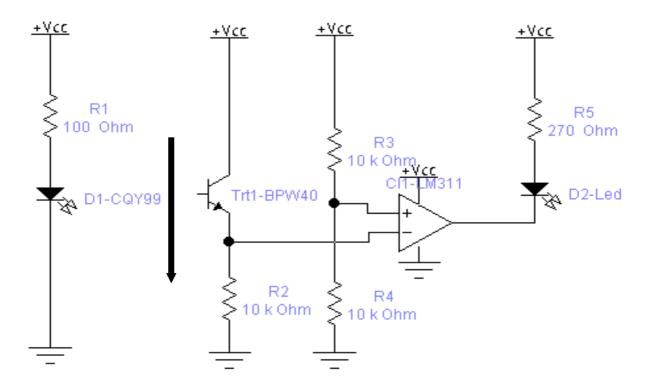
FUNDAMENTOS DE TECNOLOGÍA DE COMPUTADORES PRÁCTICAS DE LABORATORIO

Fotoemisores – Fototransistores

Se realizará el montaje de una barrera fotoeléctrica por medio de un fotoemisor y un fototransistor (fotorreceptor), ambos trabajando en el espectro infrarrojo. Esta práctica se realizará utilizando la maleta de montaje de prototipos y con componentes físicos de inserción. Nos encontramos con un componente nuevo que es un comparador de señales eléctricas (LM311). Este comparador detecta la presencia o no de un objeto interrumpiendo el haz de luz infrarroja.

Se realizarán los cálculos teóricos de las tensiones y corrientes así como las medidas físicas de corriente y tensión. Para esto ultimo, utilizaremos el polímetro como instrumento de medida.



Rellenad con los valores observados mediante los instrumentos de que disponemos, los valores de la siguiente tabla (por favor, indicad claramente las unidades):

	Con barrera entre D ₁ y Trt1	Sin barrera entre D1 y Trt1
Intensidad a través del diodo D1		
Tensión en el emisor de Trt1 (En R2)		
Tensión en entrada + al comparador (En R4)		
Tensión en la salida del comparador		
Intensidad a través del diodo D2		

La lista de componentes es la siguiente:

Resistencias	Componen
	te
100 Ω	R1
10 ΚΩ	R2,R3,R4
270 Ω	R5
Fotodiodos	
L53F3C	D1
Fototransistores	
L53P3C	Trt1
Diodos Led	
Rojo	D2
Circuitos Integrados	
LM311	CI1

Fotoemisor:

Diodo emisor de luz en el entorno del infrarrojo provisto de una lente para focalizar mejor la luz emitida.

Fototransistor:

Sensible en un espectro más amplio que comprende tanto el infrarrojo como la luz visible. Está también provisto de una lente para mejorar el enfoque.

Comparador:

Realiza la comparación entre las dos entradas, cuando el terminal (+) es mayor en valor absoluto que el terminal (-), la salida presenta un estado de alta impedancia por ser un colector abierto. Cuando el terminal (-) es mayor en valor absoluto que el terminal (+) la salida será un 0 V.

T-1 3/4 (5mm) INFRA-RED EMITTING DIODE

L-63F3C	L-63F3BT
L-53SF4C	L-53SF4BT
L-53SF8C	L-533F68T
L-StS F/C	L-533F78T

Features

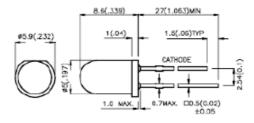
TO THE L-51P3C PHOTOTRANSISTOR. BOTH WATER CLEARLENS AND BLUE TRANSPARENT LENS AVAILABLE HIGH POWER OUTPUT.

•NECHANICALLY AND SPECTRALLY MATCHED

Description

F3Madewith Gallium Arsenide Initiared Emitting diodes. SF4 and SF6 and SF7 Made with Gallium Aluminum Arsenide Infraed Emiting diodes.

Package Dimensions



- Note:

 1. All dimensions are in millimeters (inches).

 2. Tolerance is ±0.25(0.017) unless otherwise noted.

 3. Lead apacing is measured where the lead enterings;

 4. Specifications are subject to change without notice.

SPEC NO: KDA0418

REV NO: V.1

DATE: 3EP/21/2001 PAGE: 1 OF 5 DRAWN: J.X.FU

Selection Guide

Part No.	Dice	Lens Type	Po (n @2	nWsr) 0mA	Po (n @5	Viewing Angle	
			Min.	Тур.	Min.	Тур.	291/2
L-53F3C	GaAs	WATER CLEAR	8	20	12	30	30°
L-53F3BT	GaAs	BLUE TRANS.	5	20	8	30	30°
L-53SF4C	GaAlAs	WATER CLEAR	8	20	12	30	30°
L-53SF4BT	GaAlAs	BLUE TRANS.	5	20	8	30	30°
L-53SF6C	GaAlAs	WATER CLEAR	10	40	50	100	30°
L-53SF6BT	GaAlAs	BLUE TRANS.	10	40	50	100	30°
L-53SF7C	GaAlAs	WATER CLEAR	10	40	50	100	30~
L-53SF7BT	GaAlAs	BLUE TRANS.	10	40	50	100	30°

Electrical / Optical Characteristics at T_A=25°C

Forward Voltage							
Forward Voltage	Item	P/N	Symbol	Тур.	Max.	Unit	Condition
Reverse Current	Forward Voltage	SF4 SF6	V _F	1.3 1.35	1.7 1.6	v	F=20mA
F3	Reverse Current	SF4 SF6	l _k		10 10 10 10	uA	VR=5V
Peak Spectral Wavelength	Junction Capacitance	SF4 SF6	С	90 90 30 30	-	рF	V=0 f=1MHz
Spectral Bandwidth SF6 AA 50 - Inm IF=20mA	Peak Spectral Wavelength	SF4 SF6	λP	880 860	-	nm	F=20mA
SF7 41	Spectral Bandwidth	F3 SF4 SF6 SF7	Δλ	50 50 50 41	-	nm	F=20mA

SPEC NO: KDA0438 APPROVED: J.LU

REV NO: V.1 CHECKED:

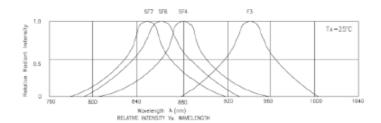
DATE: SEP/21/2001 PAGE: 2 OF 5 DRAWN: J.X.FU

Note: 1, 81/2 is the angle from optical centerline where the luminous intensity is 1/2 the optical centerline value.

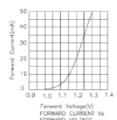
Absolute Maximum Ratings at T_A=25°C

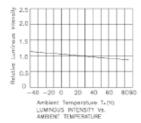
Item	Symbol	F3&SF4	SF6&SF7	Units
Power Dissipation	Pd	100	100	mW
Forward Current	ŀ	50	50	mA
Peak Forward Current	b	1.2	1	Α
Reverse Voltage	V _R	5	5	V
Operating Temperature	Topr	-40~ +85	-40~ +85	°C
Storage Temperature	Tstg	-40~ +85	-40~ +85	°C

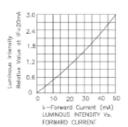
- Notes: 1. 1/10 Duty Cycle, 0.1ms Pulse Width. 2. 4mm below package base.

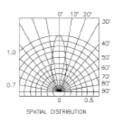


L-53F3C, L-53F3BT







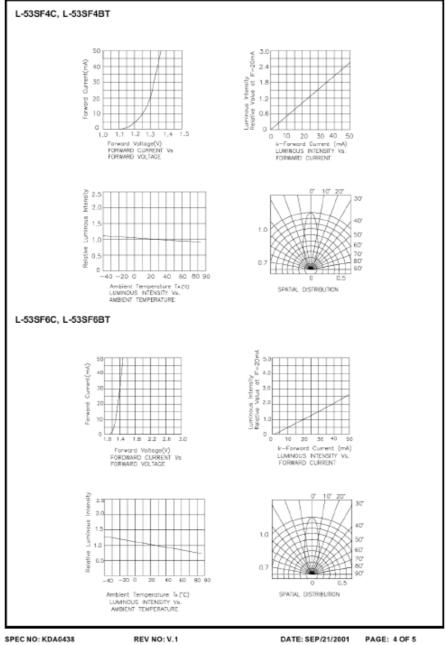


SPEC NO: KDA0438 APPROVED: J.LU

REV NO: V.1 CHECKED:

DATE: SEP/21/2001 DRAWN: J.X.FU

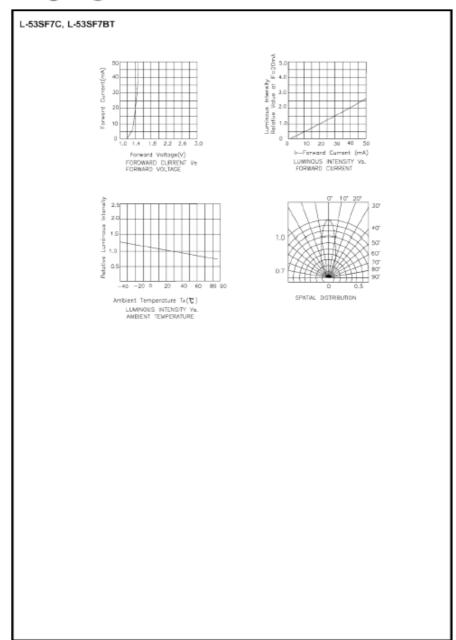
PAGE: 3 OF 5



APPROVED: J.LU

CHECKED:

DRAWN: J.X.FU



PHOTOTRANSISTOR

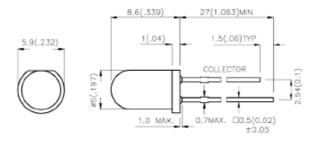
L-53P3C

•MECHANICALLY AND SPECTRALLY MATCHED TO THE L-53 SERIES INFRARED EMITTING LED LAMP. •WATER CLEAR LENS.

Description

Made with NPN silicon phototransistor chips.

Package Dimensions



- 1. All dimensions are in millimeters (inches).
 2. Tolerance is ±0.25(0.01°) unless otherwise noted.
 3. Lead spacing is measured where the lead emerge package.
 4. Specifications are subject to change without notes.

SPEC NO: DSAA4158 APPROVED : J. Lu

REV NO: V.4 CHECKED : Allen Liu DATE:MAR/06/2003 DRAWN: D.L.HUANG PAGE: 1 OF 2

Electrical / Optical Characteristics at T_A=25°C

Symbol	Parameter	Min.	Тур.	Max.	Unit	Test Condiction
VBRICEO	Collector-to-Emitter Breakdown Voltage	30	-		v	Ic=100uA E ₀ =0mW/cm²
VBRECO	Emitter-to-Collector Breakdown Voltage	5	-	-	v	I ==100uA E _e =0mW/cm²
VCE (SAT)	Collector-to-Emitter Saturation Voltage	-	-	0.8	v	Ic=2mA Ee=20m/V/cm²
ICEO	Collector Dark Current	-	-	100	nA	Vce=10V E _v =0mW/cm ²
TR	Rise Time (10% to 90%)	-	3	-	us	Vce=5V lo=1mA
Tr	Fall Time (90% to 10%)	-	3	-	us	RL=1000Ω
T _(ON)	On State Collector Current	0.1	0.5		mA	Vc=5V Ee=1mW/cm² λ=940nm

Absolute Maximum Ratings at T_A=25°C

Parameter	Maximum Rating					
Collector-to-Emitter Breakdown Voltage	30V					
Emitter-to-Collector Breakdown Voltage	5V					
Power Dissipation at (or below) 25°C Free Air Temperature	100mW					
Operating Temperature Range	-40°C ~ +85°C					
Storage Temperature Range	-40°C ~ +85°C					
Lead soldering Temperature (>5mm for 5sec)	260°C					

INTEGRATED CIRCUITS



LM111/211/311/311B

Voltage comparator

Product data Supersedes data of 1994 Aug 31 File under Integrated Circuits, IC11 Handbook 2001 Aug 03

Philips Semiconductors





Voltage comparator

LM111/211/311/311B

DESCRIPTION

The LMTI series are voltage comparators that have input currents approximately a hundred times lower than devices like the µA710. They are designed to operate over a wider range of supply voltages, from standard ±15 V pa mp supplies down to a single 3 V supply. Their output is compatible with RTL, DTL, and TTL as well as MOS circuits. Further, they can drive lamps or relays, switching voltages up to 50 V at currents as high as 50mA.

Both the inputs and the outputs of the LM111 series can be isolated from system ground, and the output can drive loads referred to ground, the positive supply, or the negative supply. Offset balancing and strobe capability are provided and outputs can be wire-ORed.

Although slower than the μ A710 (200 ns response time versus 40 ns), the devices are also much less prone to spurious oscillations. The LM111 series has the same pin configuration as the μ A710 series.

FEATURES

- Operates from single 3 V supply (LM311B)
- Maximum input bias current: 150 nA (LM311: 250 nA)
- Maximum offset current: 20 nA (LM311: 50 nA)
- Differential input voltage range: ±30 V
- Power consumption: 135 mW at ±15 V
- High sensitivity: 200 V/mV
- · Zero crossing detector

PIN CONFIGURATION

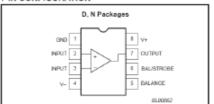


Figure 1. Pin Configuration

APPLICATIONS

- Precision squarer
- Positive/negative peak detector
- Low voltage adjustable reference supply
- Switching power amplifier

ORDERING INFORMATION

DESCRIPTION	TEMPERATURE RANGE	ORDER CODE	DWG #
8-Pin Plastic Small Outline Package (SO)	-55 °C to +125 °C	LM111D	SOT98-1
8-Pin Plastic Dual In-Line Package (DIP)	-55 °C to +125 °C	LM111N	SOT97-1
8-Pin Plastic Small Outline Package (SO)	−25 °C to +85 °C	LM211D	SOT96-1
8-Pin Plastic Dual In-Line Package (DIP)	−25 °C to +85 °C	LM211N	SOT97-1
8-Pin Plastic Small Outline Package (SO)	D °C to+70 °C	LM311D	SOT96-1
8-Pin Plastic Dual In-Line Package (DIP)	0 °C to: +70 °C	LM311N	SOT97-1
8-Pin Plastic Small Outline Package (SO)	0 °C to: +70 °C	LM311BD	SOT96-1
8-Pin Plastic Dual In-Line Package (DIP)	D °C to: +7D °C	LM311BN	SOT97-1

Voltage comparator

LM111/211/311/311B

EQUIVALENT SCHEMATIC

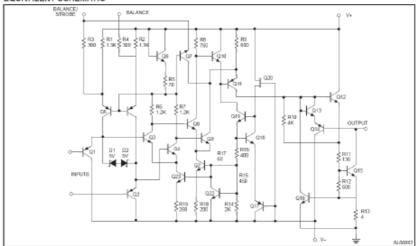


Figure 2. Equivalent Schematic

ABSOLUTE MAXIMUM RATINGS

SYMBOL	PARAMETER	RATING	UNIT
V _s	Total supply voltage	36	V
	Output to negative supply voltage:		
	LM111/LM211	50	V
	LM311/LM311B	40	V
	Ground to negative supply voltage	30	V
	Differential input voltage	±30	V
V _{IN}	Input voltage ¹	±15	٧
Po max	Maximum power dissipation, T _{amb} = 25 °C (still-air) ²		
	N peckage	1190	m/V
	D package	780	mW
I	Output short-circuit duration	10	sec
Tano	Operating ambient temperature range		
	LM111	-55 to +125	*C
	LM211	-25 to +85	°C
	LM311/LM311B	0 to +70	"C
T _{stg}	Storage temperature range	-65 to +150	"C
T _{skt}	Lead soldering temperature (10 sec max)	230	°C

2001 Aug 03

NOTES:

1. This rating applies for ±15 V supplies. The positive input voltage limit is 30 V above the negative supply. The negative input voltage limit is equal to the negative supply voltage or 30 V below the positive supply, whichever is less.

2. Derate above 25 °C, at the following rates:

N package at 8.5 mW/°C

D package at 8.2 m/V°C

Voltage comparator

LM111/211/311/311B

DC ELECTRICAL CHARACTERISTICS1, 2, 3, 6

SYMBOL	DADAMETER	TEST COMPLETIONS	LIV	1111/LM:	211		LM311			LM311E	ì	UNIT
SYMBOL	PARAMETER	TEST CONDITIONS	Min	Тур	Мах	Min	Тур	Max	Min	Тур	Max	UNII
Vos	input offset voltage ³	T _{amb} = 25 °C; R _S ≤ 50 kΩ		0.7	3.0		2.0	7.5		2.0	7.5	mV
los	Input offset ourrent ³	T _{amb} = 25 °C		4.0	10		6.0	50		6	25	nΑ
Isias	Input bias current	T _{amb} = 25 °C		60	100		100	250		100	200	пA
A _V	Voltage gain	T _{amb} = 25 °C	\Box	200			200			200		V/mV
	Response time ⁴	T _{amb} = 25 °C		200			200			500		ns
V _{SAT}	Saturation voltage	$\begin{split} & LM111/211 \ V_{IN} \le -5 mV; \\ & I_{OUT} = 50 \ mA \\ & LM311/B \ V_{IN} \le -10 \ mV; \\ & I_{OUT} = 50 \ mA \\ & T_{amb} = 25 \ ^{\circ}C \end{split}$		0.75	1.5		0.75	1.5		0.75	1.5	v
IBALISTR	Strabe on current	T _{amb} = 25 °C		3.0			3.0			3.0		mΑ
LEAKAGE	Output leakage current [©]	LM111/211 V _{IN} ≥ 5 mV; V _{OUT} = 35 V LM311/B V _{IN} ≥ 10 mV; V _{OUT} = 35 V T _{3mb} = 25 °C, IsTROGE = 3 mA (V = V _{GND} = -5 V)		0.2	10		0.2	50		0.2	50	nA
Vos	Input offset voltage ³	$R_8 \le 50 \text{ k}\Omega$			4.0			10			10	mV
los	Input offset ourrent3				20			70			50	nΑ
Islas	Input bias current				150			300			250	nΑ
V _{IN}	Input voltage range	V = ±15 V (Pin 7 may go to 5 V)	-14.5	13.8 to -14.7	13.0	-14.5	13.8 to -14.7	13.0	V- +0.5		V+ -1.5	v
VOL	Saturation voltage ⁶	$V+ \ge 4.5 \text{ V}, V- = 0 \text{ V}$ $LM111/211 \text{ V}_{IN} \le -6 \text{ m/V};$ $I_{SINK} \le 8 \text{ mA}$ $LM311/B \text{ V}_{IN} \le -10 \text{ m/V};$ $I_{SINK} \le 8 \text{ mA}$		0.23	0.4		0.23	0.4		0.23	0.4	v
loH	Output leakage current	V _{IN} ≥ 5 mV; V _{OUT} = 35 V		0.1	0.5							μА
lcc	Positive supply current	T _{amb} = 25 °C		5.1	6.0		5.1	7.5		1.6	3.5	mA
IEE	Negative supply voltage	T _{amb} = 25 °C		4.1	5.0		4.1	5.0				mA

- NOTES:
- NOTES:

 1. This rating applies for ±15 V supplies. The positive input voltage limit is 30 V above the negative supply. The negative input voltage limit is equal to the negative supply voltage or 30 V below the positive supply, whichever is less.

 2. These specifications apply for V_S ±±15 V and 0 °C < T_{angle} <70 °C unless otherwise specifications apply for V_S ±±15 V and 0 °C < T_{angle} <70 °C unless otherwise specifications are limited to ~25 °C < T_{angle} <+15 °C, and for the LM111 is limited to ~55 °C < T_{angle} <+125 °C. The offset voltage, offset current, and bias current specifications apply for any supply voltage from a single 5 V supply up to ±15 V supplies.

 3. The offset voltages and offset currents given are the maximum values required to drive the body within a volt of either supply with 1 mA losd. Thus, these parameters define an error bend and take into account the worst case effects of voltage gain and input impedance.

 4. The response time specified is for a 100 mV input step with 5 mV over-drive.

 5. Do not short the strobe pin to ground; it should be current driven at 3 mA to 5 mA.

 6. LM391B, all parameters are at V+ = 3 V ±10%; V = GND = 0 V.

2001 Aug 03

Voltage comparator

LM111/211/311/311B

TYPICAL APPLICATIONS

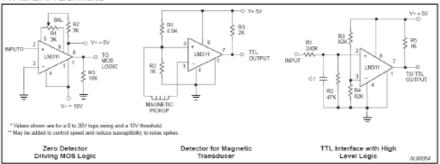


Figure 3. Typical Applications

2001 Aug 03 5

Voltage comparator

LM111/211/311/311B

 \Box \Diamond

95-02-04 99-12-27

DIP8: plastic dual in-line package; 8 leads (300 mil) SOT97-1 Z (1) max. D⁽¹⁾ E⁽¹⁾ МЕ ь L M_{H} UNIT e₁ 10.0 8.3 0.53 0.38 1.07 0.89 8.25 7.80 0.36 9.8 9.2 6.48 6.20 3.60 3.05 1.73 1.15 mm 0.254 4.2 0.51 32 2.54 7.02 0.32 inches 0.068 0.042 0.10 0.01 0.045 0.17 0.020 0.13 0.30 Note 1. Plastic or metal protrusions of 0.25 mm maximum per side are not included. REFERENCES OUTLINE VERSION EUROPEAN PROJECTION ISSUE DATE IEC JEDEC EIAJ

SC-504-8

2001 Aug 03 6

MO-001

050G01

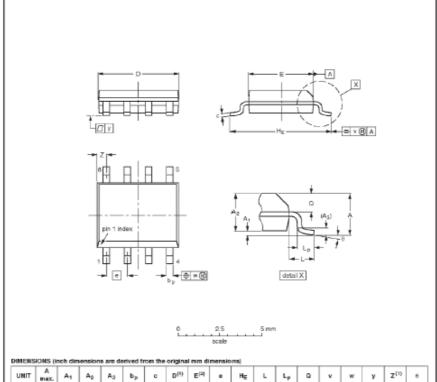
SOT97-1

Voltage comparator

LM111/211/311/311B

SO8: plastic small outline package; 8 leads; body width 3.9 mm





UNIT	A max.	A ₁	A ₂	Aa	bp	с	D(1)	E ⁽²⁾	e	HE	L	Lp	a	v	w	у	Ζ ⁽¹⁾	е
mm	1.75	0.25 0.10	1.45 1.25	0.25	0.49 0.36	0.25 0.19	5.0 4.8	4.0 3.8	1.27	62 5.8	1.05	1.0 0.4	0.7	0.25	0.25	0.1	0.7 0.3	e°
inches	0.069	0.010 0.004	0.057 0.049	0.01	0.019 0.014	0.0100 0.0075	0.20 0.19	0.16 0.15	0.050	0.244	0.041	0.039	0.028	0.01	0.01	0.004	0.028	a,

- Notes
 1. Plastic or metal probusions of 0.15 mm maximum per side are not included.
 2. Plastic or metal probusions of 0.25 mm maximum per side are not included.

	OUTLINE VERSION	REFERENCES			EUROPEAN	ISSUE DATE	
ı		IEC	JEDEC	EIAJ		PROJECTION	BOULDATE
	SCT96-1	076E03	MS-012			□ ©	97-08-22 99-12-27

2001 Aug 03

Voltage comparator

LM111/211/311/311B

Data sheet status

Data sheet status [1]	Product status [2]	Definitions		
Objective data	Development	This data sheet contains data from the objective specification for product development. Philips Semiconductors reserves the right to change the specification in any manner without notice.		
Preliminary data	Qualification	This data sheet contains data from the preliminary specification. Supplementary data will be published at a later date. Philips Semiconductors reserves the right to change the specification without notice, in order to improve the design and supply the best possible product.		
Product data	Production	This data sheet contains data from the product specification. Philips Semiconductors reserves the right to make changes at any time in order to improve the design, manufacturing and supply. Changes will be communicated according to the Customer Product/Process Change Notification (CPCN) procedure SNM-SQ-650A.		

- [1] Please consult the most recently issued data sheet before initiating or completing a design.
- [2] The product status of the device(x) described in this data sheet may have changed since this data sheet was published. The latest information is available on the Internet at URL http://www.samiconductors.philips.com.

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Short-form specification — The data in a short-form specification is extracted from a full data sheet with the same type number and title. For detailed information see the relevant data sheet or data handbook.

Limiting values definition — Limiting values given are in accordance with the Absolute Maximum Rating System (EC 60134). Stress above one or more of the limiting values may cause permanent damage to the device. These are stress ratings only and operation of the device at these or at any other conditions above those given in the Characteristics sections of the specification is not implied. Exposure to limiting values for extended periods may affect device reliability.

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